



# MICROSCOPY & OPTICAL METROLOGY WORKSHOP

## OLYMPUS TECH TOURS

Bring technology & expertise to your institution

- 3D Imaging
- Laser Confocal Technology
- Digital Microscopy
- Roughness Analysis

“Surface Metrology for correlating and discriminating surface topographies with their performance and processing.” by Dr. Christopher A. Brown, Worcester Polytechnic Institute, Professor of Mechanical Engineering.

### Purdue University

Burton D Morgan Center for Entrepreneurship,  
Room 121, 1201 West State Street

**April 27, 2011**

**9-12 p.m.** - Technical Presentation at Burton D Morgan Center (10:30 a.m. – Keynote speaker)

**1-5 p.m.** - Hands-on Workshops at Birck Nanotechnology Center (1205 W. State Street) **Bring your samples!**

Contact: Chris Vander Tuuk  
Email: [christopher.vandertuuk@olympus.com](mailto:christopher.vandertuuk@olympus.com)  
Phone: 815-514-3914

Contact: Shawn Galdeen  
Email: [shawn.galdeen@olympus.com](mailto:shawn.galdeen@olympus.com)  
Phone: 317-445-1180  
or visit [www.olympusamerica.com/techtours](http://www.olympusamerica.com/techtours)

Advancing the  
**Science**  
of **Industry**